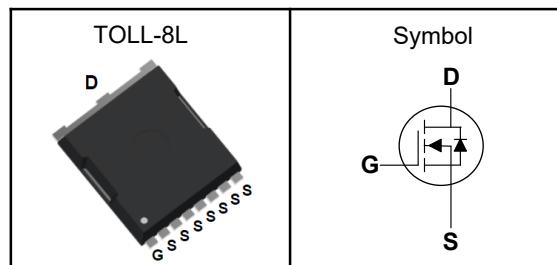


## N-Channel Enhancement Mode MOSFET

### Features

- High Speed Power Switching
- Reliable and Rugged
- ROHS Compliant
- 100% Avalanche Tested

### Pin Description



### Applications

- Power Management in Desktop Computer
- DC/DC Converters

$V_{DSS}$	100	V
$R_{DS(ON)-Typ}$	1.4	$m\Omega$
$I_D$	312	A

### Absolute Maximum Ratings ( $T_C=25^\circ C$ , Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit
$V_{DSS}$	Drain-Source Voltage	100	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	V
$T_J$	Maximum Junction Temperature	-55 to 150	$^\circ C$
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ C$
$I_{DM}^{①}$	Pulse Drain Current Tested	1248	A
$I_D$	Continuous Drain Current	312	A
$P_D$	Maximum Power Dissipation	391	W
$E_{AS}$	Avalanche Energy, Single pulse	1250	mJ

### Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	39	$^\circ C/W$
$R_{\theta JC}$	Thermal Resistance-Junction to Case	0.32	$^\circ C/W$

Note ① : Max. current is limited by bonding wire.

Note ② : UIS tested and pulse width are limited by maximum junction temperature  $150^\circ C$ .

Note ③ : Surface Mounted on 1in<sup>2</sup> FR-4 board with 1oz.

## N-Channel Enhancement Mode MOSFET

**Electrical Characteristics** ( $T_J=25^\circ\text{C}$ , Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>Static Electrical Characteristics</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}$ , $\text{I}_D=250\mu\text{A}$	100	---	---	V
$\text{I}_{\text{DSS}}$	Zero Gate Voltage Drain Current	$\text{V}_{\text{DS}}=100\text{V}$ , $\text{V}_{\text{GS}}=0\text{V}$	---	---	1	$\mu\text{A}$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}$ , $\text{I}_D=250\mu\text{A}$	2	---	4	V
$\text{I}_{\text{GSS}}$	Gate Leakage Current	$\text{V}_{\text{GS}}=\pm 20\text{V}$ , $\text{V}_{\text{DS}}=0\text{V}$	---	---	$\pm 100$	$\text{nA}$
$\text{R}_{\text{DS(ON)}}$	Drain-Source On-state Resistance	$\text{V}_{\text{GS}}=10\text{V}$ , $\text{I}_D=20\text{A}$	---	1.4	1.85	$\text{m}\Omega$
<b>Dynamic Characteristics<sup>⑤</sup></b>						
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{DS}}=50\text{V}$ , $\text{V}_{\text{GS}}=0\text{V}$ , Freq.=1MHz	---	14300	---	pF
$\text{C}_{\text{oss}}$	Output Capacitance		---	2120	---	
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance		---	50	---	
$\text{T}_{\text{d(on)}}$	Turn-on Delay Time	$\text{V}_{\text{DD}}=50\text{V}$ , $\text{V}_{\text{GS}}=10\text{V}$ , $\text{I}_D=20\text{A}$ , $\text{R}_G=3\Omega$	---	41	---	nS
$\text{T}_r$	Turn-on Rise Time		---	88	---	
$\text{T}_{\text{d(off)}}$	Turn-off Delay Time		---	163	---	
$\text{T}_f$	Turn-off Fall Time		---	98	---	
$\text{Q}_g$	Total Gate Charge	$\text{V}_{\text{DS}}=50\text{V}$ , $\text{V}_{\text{GS}}=10\text{V}$ , $\text{I}_D=20\text{A}$	---	250	---	nC
$\text{Q}_{\text{gs}}$	Gate-Source Charge		---	53	---	
$\text{Q}_{\text{gd}}$	Gate-Drain Charge		---	77	---	
<b>Source-Drain Characteristics</b>						
$\text{V}_{\text{SD}}$	Diode Forward Voltage	$\text{I}_S=20\text{A}$ , $\text{V}_{\text{GS}}=0\text{V}$	---	---	1.2	V
$\text{t}_{\text{rr}}$	Reverse Recovery Time	$\text{I}_F=20\text{A}$ , $\text{V}_{\text{GS}}=0\text{V}$ , $d\text{I}/dt=100\text{A}/\mu\text{s}$	---	106	---	nS
$\text{Q}_{\text{rr}}$	Reverse Recovery Charge		---	245	---	nC

Note ④: Pulse test (pulse width $\leq 300\mu\text{s}$ , duty cycle $\leq 2\%$ ).

Note ⑤ : Guaranteed by design, not subject to production testing.

## N-Channel Enhancement Mode MOSFET

### Typical Characteristics

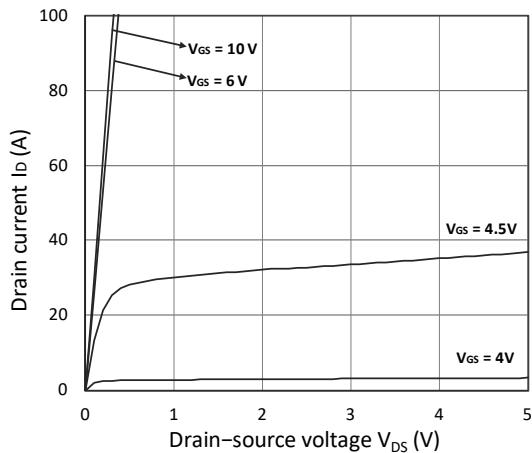


Figure 1. Output Characteristics

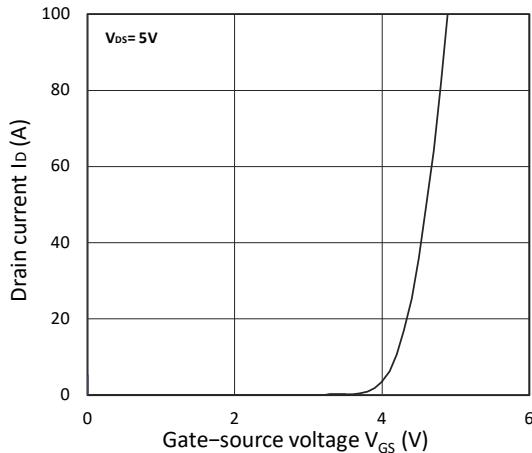


Figure 2. Transfer Characteristics

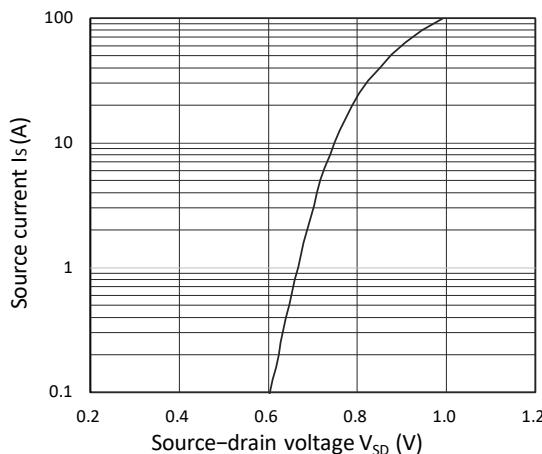


Figure 3. Forward Characteristics of Reverse

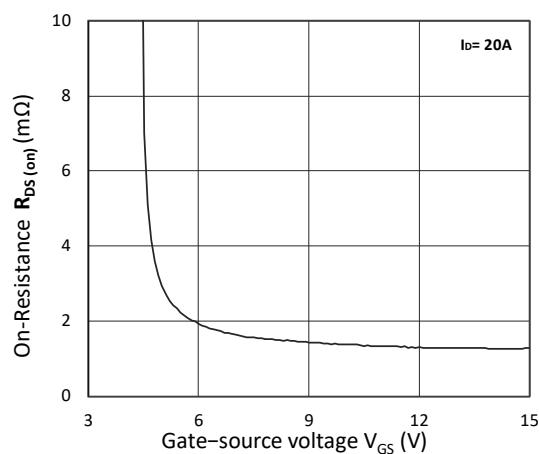


Figure 4.  $R_{DS(on)}$  vs.  $V_{GS}$

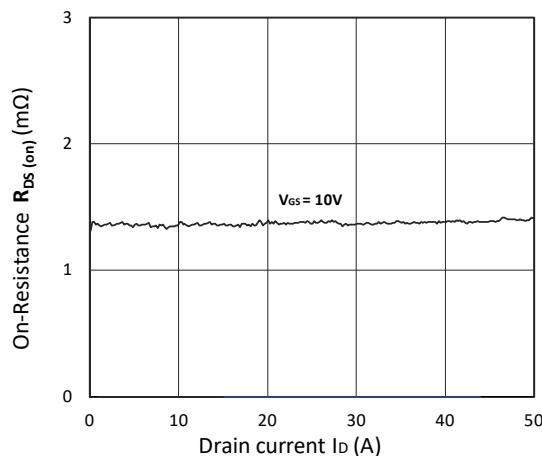


Figure 5.  $R_{DS(on)}$  vs.  $I_D$

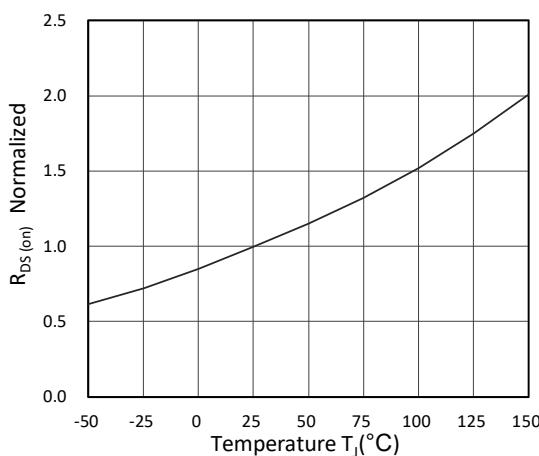


Figure 6. Normalized  $R_{DS(on)}$  vs. Temperature

## N-Channel Enhancement Mode MOSFET

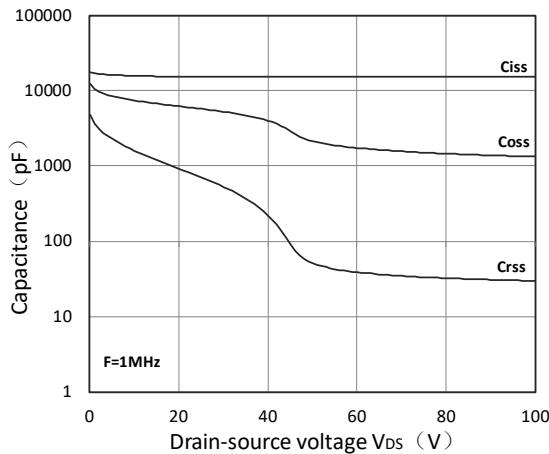


Figure 7. Capacitance Characteristics

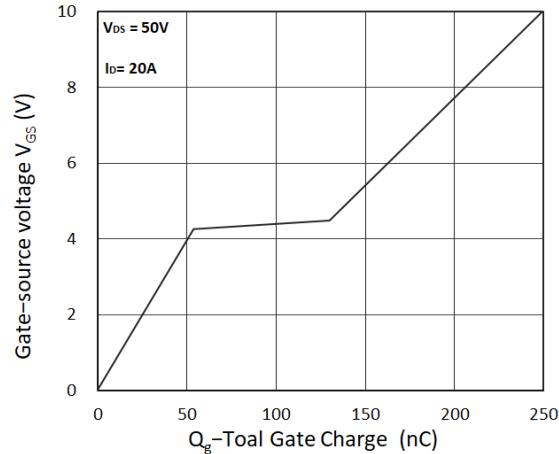


Figure 8. Gate Charge Characteristics

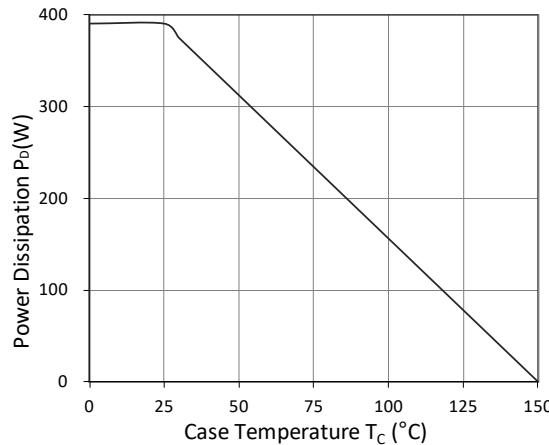


Figure 9. Power Dissipation

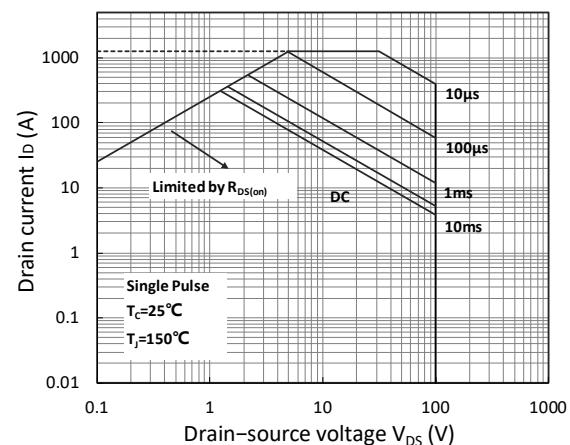


Figure 10. Safe Operating Area

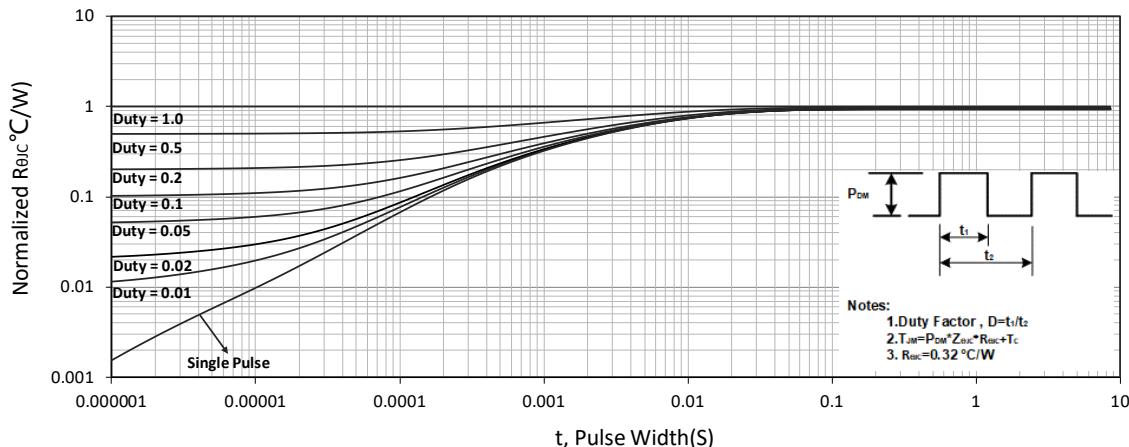
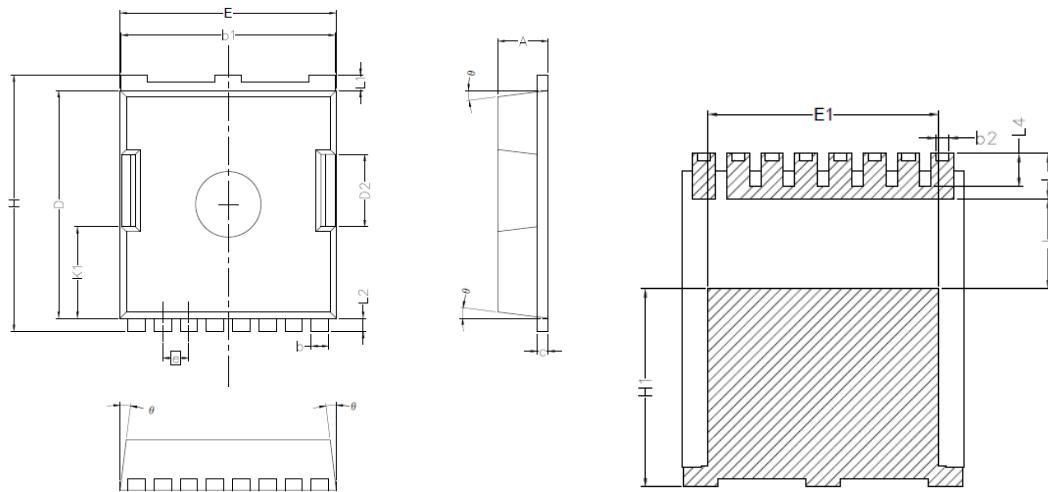


Figure 11. Normalized Maximum Transient Thermal Impedance

**N-Channel Enhancement Mode MOSFET**
**TOLL-8L Package Outline Data**


Symbol	Dimensions In Millimeters	
	MIN.	MAX.
A	2.20	2.40
b	0.70	0.90
b1	9.70	9.90
b2	0.42	0.50
c	0.40	0.60
D	10.28	10.58
D2	3.10	3.60
E	9.70	10.10
E1	7.90	8.30
e	1.20BSC	
H	11.48	11.88
H1	6.75	7.15
N	8	
J	3.00	3.30
K1	3.98	4.38
L	1.40	1.80
L1	0.60	0.80
L2	0.50	0.70
L4	1.00	1.30
θ	4°	10°